ON Semiconductor

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MOSFET – Power, Single, N-Channel, DPAK/IPAK 30 V, 36 A

Features

- Low R_{DS(on)} to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- Optimized Gate Charge to Minimize Switching Losses
- Three Package Variations for Design Flexibility
- These Devices are Pb-Free, Halogen Free/BFR Free and are RoHS Compliant

Applications

- CPU Power Delivery
- DC-DC Converters

MAXIMUM RATINGS ($T_J = 25^{\circ}C$ unless otherwise stated)

Pa	Symbol	Value	Unit		
Drain-to-Source Vo	Drain-to-Source Voltage				
Gate-to-Source Vo	V_{GS}	±20	V		
Continuous Drain Current R _{θJA} (Note 1)		$T_A = 25^{\circ}C$ $T_A = 100^{\circ}C$	Ι _D	11.6 8.2	Α
Power Dissipation R ₀ JA (Note 1)		T _A = 25°C	P _D	2.55	W
Continuous Drain		T _A = 25°C	Ι _D	8.5	Α
Current R _{θJA} (Note 2)	Steady State	T _A = 100°C		6.0	
Power Dissipation R _{θJA} (Note 2)	State	T _A = 25°C	P_{D}	1.38	W
Continuous Drain Current R _{θJC} (Note 1)		$T_C = 25^{\circ}C$ $T_C = 100^{\circ}C$	I _D	36 25	Α
Power Dissipation R ₀ JC (Note 1)		T _C = 25°C	P _D	24.6	W
Pulsed Drain Current	t _p =10μs	T _A = 25°C	I _{DM}	130	Α
Current Limited by F	Package	T _A = 25°C	I _{DmaxPkg}	38	Α
Operating Junction Temperature	Operating Junction and Storage Temperature				°C
Source Current (Bo	IS	22	Α		
Drain to Source dV/	dV/dt	6.0	V/ns		
Single Pulse Drain-to-Source Avalanche Energy (T_J = 25°C, V_{DD} = 24 V, V_{GS} = 10 V, I_L = 15 A_{pk} , L = 0.1 mH, R_G = 25 Ω)			EAS	11	mJ
Lead Temperature f		Purposes	TL	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

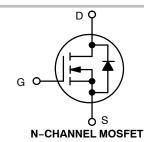
- 1. Surface-mounted on FR4 board using 1 sq-in pad, 1 oz Cu.
- 2. Surface-mounted on FR4 board using the minimum recommended pad size.



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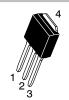
http://onsemi.com

V _{(BR)DSS}	R _{DS(ON)} MAX	I _D MAX	
30 V	11 mΩ @ 10 V	36 A	
33 V	21 mΩ @ 4.5 V	30 A	







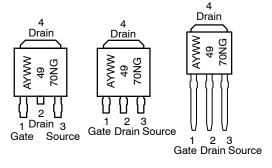


CASE 369AA DPAK (Bent Lead) STYLE 2

CASE 369AC 3 IPAK (Straight Lead)

CASE 369D IPAK (Straight Lead DPAK)

MARKING DIAGRAMS & PIN ASSIGNMENTS



A = Assembly Location

Y = Year WW = Work Week 4970N = Device Code G = Pb-Free Package

ORDERING INFORMATION

See detailed ordering and shipping information in the package dimensions section on page 3 of this data sheet.

THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case (Drain)	$R_{ heta JC}$	6.1	°C/W
Junction-to-TAB (Drain)	$R_{\theta JC-TAB}$	4.3	
Junction-to-Ambient - Steady State (Note 3)	$R_{\theta JA}$	58.9	
Junction-to-Ambient - Steady State (Note 4)	$R_{ heta JA}$	108.9	

- 3. Surface-mounted on FR4 board using 1 sq-in pad, 1 oz Cu.
- 4. Surface-mounted on FR4 board using the minimum recommended pad size.

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS	•						
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		30			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /				17		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	I_{DSS} $V_{GS} = 0 \text{ V},$ $T_{J} = 25^{\circ}\text{C}$				1.0	
		V _{DS} = 24 V	T _J = 125°C			10	μΑ
Gate-to-Source Leakage Current	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS}$	_S = ±20 V			±100	nA
ON CHARACTERISTICS (Note 5)							
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_{D}$	= 250 μA	1.5	1.9	2.5	V
Negative Threshold Temperature Coefficient	V _{GS(TH)} /T _J				4.5		mV/°C
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 30 A		8.3	11	
			I _D = 15 A		8.2		
		V _{GS} = 4.5 V	I _D = 30 A		14.6	21	mΩ
			I _D = 15 A		13.2		1
Forward Transconductance	9 _{FS}	V _{DS} = 1.5 V, I _D = 30 A			34		S
CHARGES, CAPACITANCES AND GATE	RESISTANCE						
Input Capacitance	C _{ISS}				774		
Output Capacitance	C _{OSS}	V _{GS} = 0 V, f = 1.0 M	Hz, V _{DS} = 15 V		306		pF
Reverse Transfer Capacitance	C _{RSS}				161		1
Total Gate Charge	Q _{G(TOT)}				8.2		
Threshold Gate Charge	Q _{G(TH)}		45.77.1 00.4		1.5		
Gate-to-Source Charge	Q_GS	$V_{GS} = 4.5 \text{ V}, V_{DS} =$	15 V, I _D = 30 A		3.0		nC
Gate-to-Drain Charge	Q_{GD}				4.0		
Total Gate Charge	Q _{G(TOT)}	V _{GS} = 10 V, V _{DS} = 15 V, I _D = 30 A			15.8		nC
SWITCHING CHARACTERISTICS (Note				-	<u>-</u>	-	-
Turn-On Delay Time	t _{d(ON)}				10		
Rise Time	t _r	V _{GS} = 4.5 V, V	ns = 15 V.		27.6		1
Turn-Off Delay Time	t _{d(OFF)}	$I_D = 15 \text{ A}, R_G = 3.0 \Omega$			12.5		ns

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions. 5. Pulse Test: pulse width \leq 300 μ s, duty cycle \leq 2%.

- 6. Switching characteristics are independent of operating junction temperatures.

7. Assume terminal length of 110 mils.

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise specified)

Parameter	Symbol	Test Condi	tion	Min	Тур	Max	Unit
SWITCHING CHARACTERISTICS (No	ote 6)						
Turn-On Delay Time	t _{d(ON)}				6.3		
Rise Time	t _r	V _{GS} = 10 V, V _{DS}	s = 15 V,		19.5		ns
Turn-Off Delay Time	t _{d(OFF)}	$V_{GS} = 10 \text{ V, } V_{DS}$ $I_D = 15 \text{ A, } R_G = 10 \text{ N}$	= 3.0 Ω		16.2		
Fall Time	t _f				3.7		
DRAIN-SOURCE DIODE CHARACTE	RISTICS						
Forward Diode Voltage	V _{SD}	$V_{GS} = 0 \text{ V}.$ $T_J = 25^{\circ}\text{C}$			0.97	1.1	
		$V_{GS} = 0 \text{ V},$ $I_S = 30 \text{ A}$ $I_J = 25^{\circ}\text{C}$ $I_J = 125^{\circ}\text{C}$		0.88		V	
Reverse Recovery Time	t _{RR}				19.6		
Charge Time	t _a	V _{GS} = 0 V, dIS/dt =	= 100 A/μs,		10.2		ns
Discharge Time	t _b	I _S = 30 A			9.4		
Reverse Recovery Charge	Q _{RR}				7.0		nC
PACKAGE PARASITIC VALUES				-			
Source Inductance (Note 7)	L _S	T _A = 25°C			2.85		nH
Drain Inductance, DPAK	L _D				0.0164		
Drain Inductance, IPAK (Note 7)	L _D				1.88		
Gate Inductance (Note 7)	L _G				4.9		
Gate Resistance	R_{G}	1			0.8	2.2	Ω

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions. 5. Pulse Test: pulse width \leq 300 μ s, duty cycle \leq 2%.

- 6. Switching characteristics are independent of operating junction temperatures.
 7. Assume terminal length of 110 mils.

ORDERING INFORMATION

Device	Package	Shipping [†]
NTD4970NT4G	DPAK (Pb-Free)	2500 / Tape & Reel
NTD4970N-1G	IPAK (Pb-Free)	75 Units / Rail
NTD4970N-35G	IPAK Trimmed Lead (Pb-Free)	75 Units / Rail

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

TYPICAL PERFORMANCE CURVES

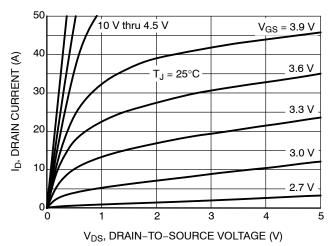
50

40

30

20

 $V_{DS} = 10 V$

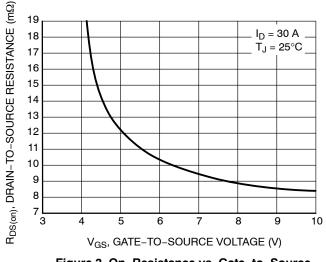


ID, DRAIN CURRENT (A) $T_J = 25^{\circ}C$ 10 $T_{J} = 125^{\circ}$ = -55°C 0 3

Figure 1. On-Region Characteristics

VGS, GATE-TO-SOURCE VOLTAGE (V) Figure 2. Transfer Characteristics

4



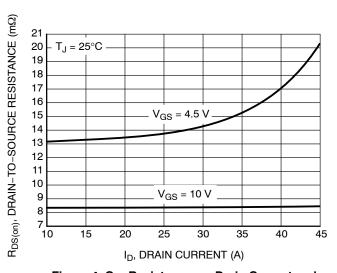
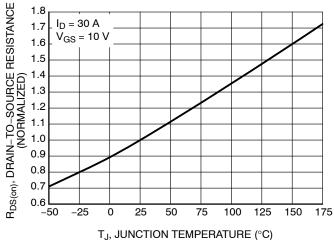


Figure 3. On-Resistance vs. Gate-to-Source Voltage

Figure 4. On-Resistance vs. Drain Current and **Gate Voltage**



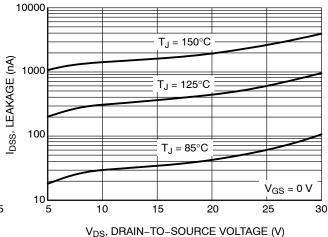
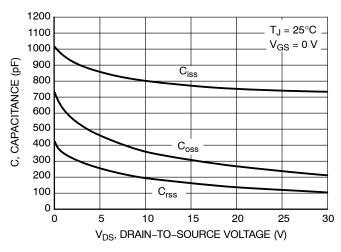


Figure 5. On-Resistance Variation with **Temperature**

Figure 6. Drain-to-Source Leakage Current vs. Voltage

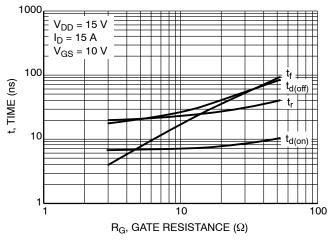
TYPICAL PERFORMANCE CURVES



10 V_{GS}, GATE-TO-SOURCE VOLTAGE (V) 9 8 7 6 5 Q_{gs} 4 3 I_D = 30 A $T_{.J} = 25^{\circ}C$ 2 $V_{DD} = 15 V$ $V_{GS} = 10 A$ 0 0 5 6 7 8 9 10 11 12 13 14 15 16 Q_G, TOTAL GATE CHARGE (nC)

Figure 7. Capacitance Variation

Figure 8. Gate-to-Source and Drain-to-Source Voltage vs. Total Charge



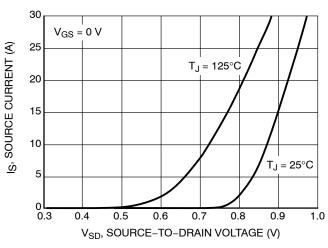
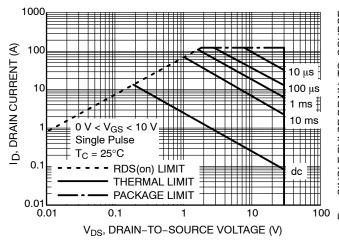


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

Figure 10. Diode Forward Voltage vs. Current



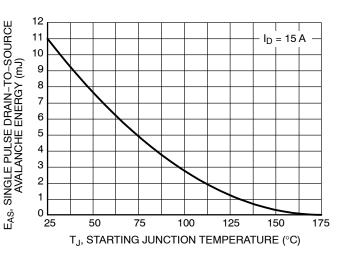


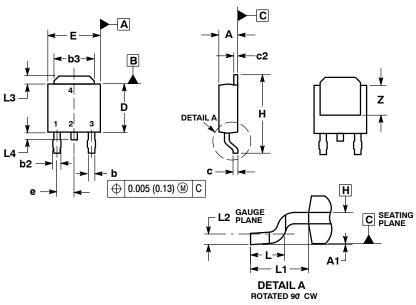
Figure 11. Maximum Rated Forward Biased Safe Operating Area

Figure 12. Maximum Avalanche Energy vs. Starting Junction Temperature

PACKAGE DIMENSIONS

DPAK (SINGLE GUAGE)

CASE 369AA **ISSUE B**



NOTES:

- NOTES:

 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.

 2. CONTROLLING DIMENSION: INCHES.

 3. THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSIONS b3, L3 and Z.

 4. DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR BURRS. MOLD FLASH, PROTRUSIONS, OR GATE BURRS SHALL NOT EXCEED 0.006 INCHES PER SIDE.

 5. DIMENSIONS D AND E ARE DETERMINED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY.

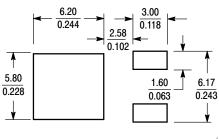
 6. DATUMS A AND B ARE DETERMINED AT DATUM
- 6. DATUMS A AND B ARE DETERMINED AT DATUM PLANE H.

	INCHES		MILLIM	IETERS
DIM	MIN	MAX	MIN	MAX
Α	0.086	0.094	2.18	2.38
A1	0.000	0.005	0.00	0.13
b	0.025	0.035	0.63	0.89
b2	0.030	0.045	0.76	1.14
b3	0.180	0.215	4.57	5.46
С	0.018	0.024	0.46	0.61
c2	0.018	0.024	0.46	0.61
D	0.235	0.245	5.97	6.22
Е	0.250	0.265	6.35	6.73
е	0.090 BSC		2.29	BSC
Н	0.370	0.410	9.40	10.41
L	0.055	0.070	1.40	1.78
L1	0.108 REF		2.74 REF	
L2	0.020	BSC	0.51 BSC	
L3	0.035	0.050	0.89	1.27
L4		0.040		1.01
Z	0.155		3.93	

STYLE 2: PIN 1. GATE 2. DRAIN 3. SOURCE

4. DRAIN

SOLDERING FOOTPRINT*



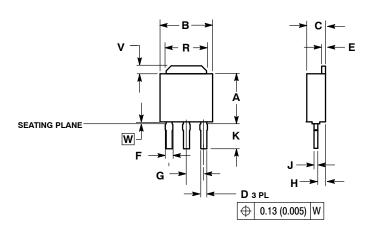
 $\left(\frac{\text{mm}}{\text{inches}}\right)$ SCALE 3:1

^{*}For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

PACKAGE DIMENSIONS

3 IPAK, STRAIGHT LEAD

CASE 369AC **ISSUE O**

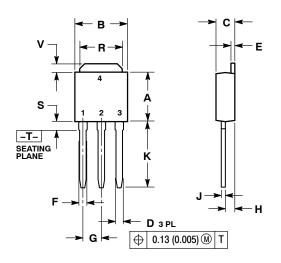


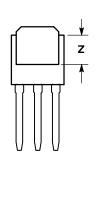
NOTES:

- 1.. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
- CONTROLLING DIMENSION: INCH.
 SEATING PLANE IS ON TOP OF DAMBAR POSITION.
 DIMENSION A DOES NOT INCLUDE
- DAMBAR POSITION OR MOLD GATE.

	INCHES		MILLIN	IETERS
DIM	MIN	MAX	MIN	MAX
Α	0.235	0.245	5.97	6.22
В	0.250	0.265	6.35	6.73
С	0.086	0.094	2.19	2.38
D	0.027	0.035	0.69	0.88
Е	0.018	0.023	0.46	0.58
F	0.037	0.043	0.94	1.09
G	0.090	0.090 BSC		BSC
Н	0.034	0.040	0.87	1.01
J	0.018	0.023	0.46	0.58
K	0.134	0.142	3.40	3.60
R	0.180	0.215	4.57	5.46
٧	0.035	0.050	0.89	1.27
w	0.000	0.010	0.000	0.25

IPAK CASE 369D ISSUE C





- DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982
- CONTROLLING DIMENSION: INCH.

	INC	HES	MILLIM	IETERS
DIM	MIN	MAX	MIN	MAX
Α	0.235	0.245	5.97	6.35
В	0.250	0.265	6.35	6.73
С	0.086	0.094	2.19	2.38
D	0.027	0.035	0.69	0.88
E	0.018	0.023	0.46	0.58
F	0.037	0.045	0.94	1.14
G	0.090	BSC	2.29	BSC
Н	0.034	0.040	0.87	1.01
J	0.018	0.023	0.46	0.58
K	0.350	0.380	8.89	9.65
R	0.180	0.215	4.45	5.45
S	0.025	0.040	0.63	1.01
٧	0.035	0.050	0.89	1.27
Z	0.155		3.93	

STYLE 2:

GATE

- 2 DRAIN SOURCE
- DRAIN

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